

11th European Symposium on Semiconductor Detectors

Wednesday, 10 June 2009

System Integration - Main Auditorium (14:20 - 15:40)

time	[id] title	presenter
14:20	[8] Development of Vertically Integrated Circuits for Particle Detectors	TRIMPL, Marcel
14:40	[11] Vertically integrated deep n-well CMOS MAPS with sparsification capabilities for thin charged particle trackers	RATTI, Lodovico
15:00	[9] Application of Si-strip technology to x-ray diffraction instrumentation	GERNDT, Ekkehard K
15:20	[51] New opportunities with Single-Photon Counting Pixel Detectors for Scientific Applications	BROENNIMANN, Christian